

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Bhattacharya et al.

Appl. No. 10/020,208

Filed: December 18, 2001

For: System and Method to Screen

Defect Related Reliability Failures

in CMOS SRAMS

Confirmation No.: 7966

Art Unit:

Examiner: Auduong, Gene Nghia

mber 18, 2001 em and Method to Screen ect Related Reliability Failures MOS SRAMS Amendment and Reply under 37 C.F.R. § 1.111 2800 MAIL ROOM

Commissioner for Patents PO Box 1450 Alexandria, VA 22313-1450

Sir:

In reply to the Office Action dated May 22, 2003, (PTO Prosecution File Wrapper Paper No. 6), Applicants submit the following Amendment and Remarks. This Amendment is provided in the following format:

- (A) Each section begins on a separate sheet;
- (B) Starting on a separate sheet, amendments to the specification by presenting replacement paragraphs marked up to show changes made;
- (C) Starting on a separate sheet, a complete listing of all of the claims:
 - in ascending order;
 - with status identifiers; and
 - with markings in the currently amended claims;
- (D) Starting on a separate sheet, the Remarks.

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It is not believed that extensions of time or fees for net addition of claims are required beyond those that may otherwise be provided for in documents accompanying this paper. However, if additional extensions of time are necessary to prevent abandonment of this application, then such extensions of time are hereby petitioned under 37 C.F.R. § 1.136(a), and any fees required therefor (including fees for net addition of claims) are hereby authorized to be charged to our Deposit Account No. 19-0036.